

Single P-Channel MOSFET

■ DESCRIPTION

SMC2869ESC used trench technology are well suited for high efficiency fast switching applications, this MOSFET has been designed to minimize the on-state resistance and yet maintain superior switching performance, this devices are well suited for applications in the small surface mount package.

■ PART NUMBER INFORMATION

SMC 2869 E SC - TR G

a	b	c	d	e	f
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a : Company name

b : Product Serial number

c : ESD Protection

d : Package code SC: SOT-523

e : Handling code TR: Tape&Reel

f : Green produce code G: RoHS Compliant

■ FEATURES

$V_{DS}=-20V$, $I_D=-0.54A$

$R_{DS(ON)}=560m\Omega$ (Typ.)@ $V_{GS}=-4.5V$

$R_{DS(ON)}=740m\Omega$ (Typ.)@ $V_{GS}=-2.5V$

$R_{DS(ON)}=1000m\Omega$ (Typ.)@ $V_{GS}=-1.8V$

$R_{DS(ON)}=1400m\Omega$ (Typ.)@ $V_{GS}=-1.5V$

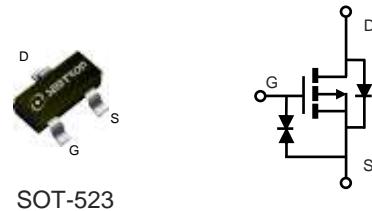
◆ High-speed switching, Low On-resistance

◆ 1.5V Low gate drive

◆ ESD protected

■ APPLICATIONS

◆ Load switch application for portable



■ ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ C$ Unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-Source Voltage	-20	V
V_{GSS}	Gate-Source Voltage	± 8	V
I_D	Continuous Drain Current $T_A=25^\circ C$	-0.54	A
		$T_A=70^\circ C$	A
I_{DM}	Pulsed Drain Current ^B	-1.8	A
P_D	Power Dissipation ^A $T_A=25^\circ C$	0.3	W
		$T_A=70^\circ C$	W
T_J	Operation Junction Temperature	-55/150	$^\circ C$
T_{STG}	Storage Temperature Range	-55/150	$^\circ C$

■ THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ^{AC} Steady-State		415	$^\circ C/W$

ELECTRICAL CHARACTERISTICS($T_A=25^\circ\text{C}$ Unless otherwise noted)

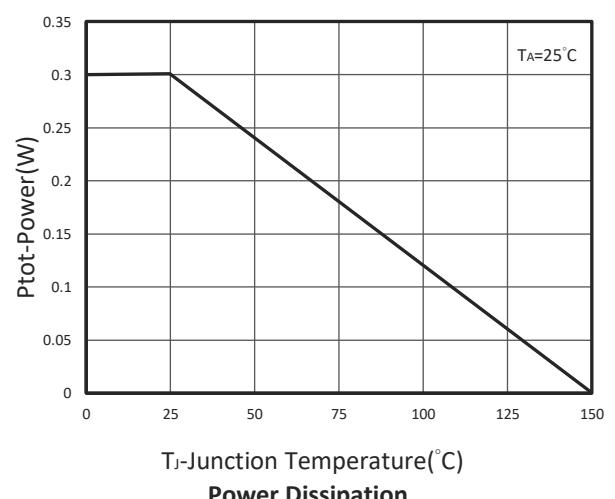
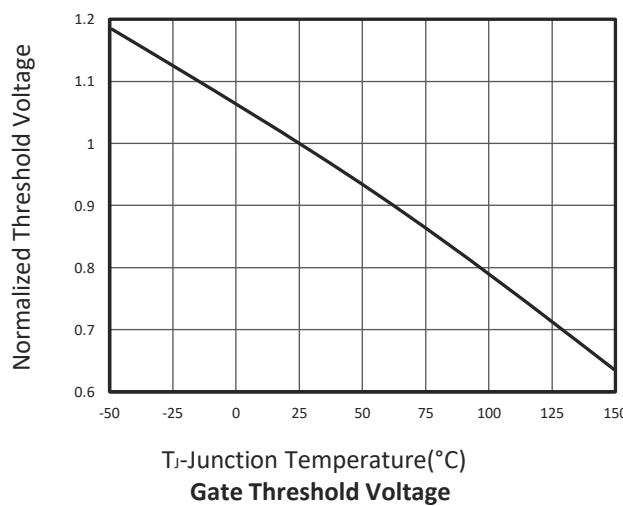
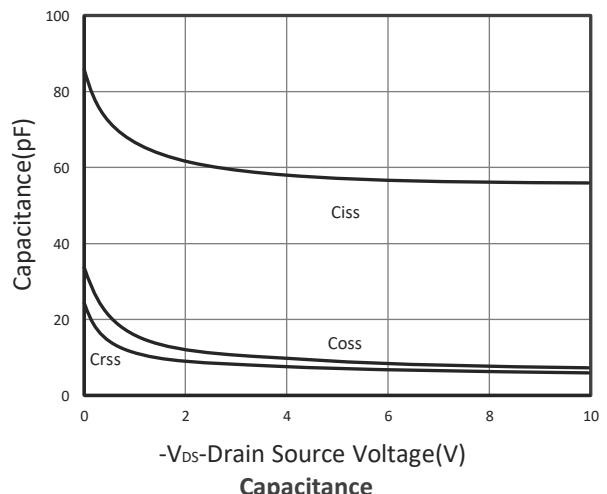
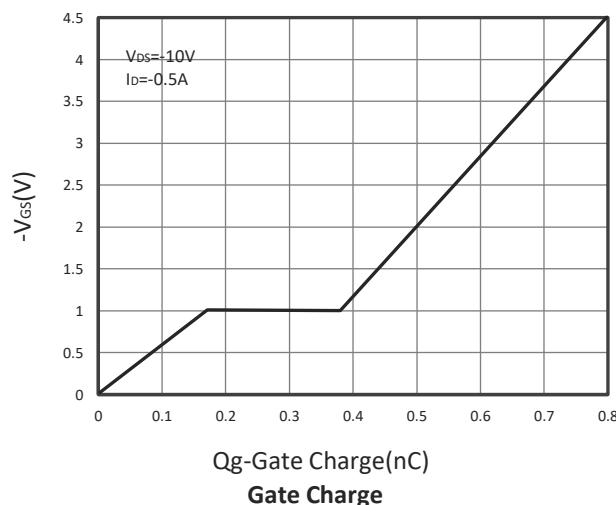
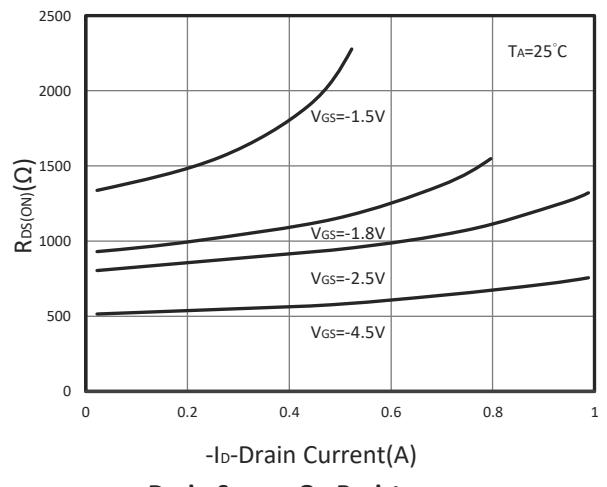
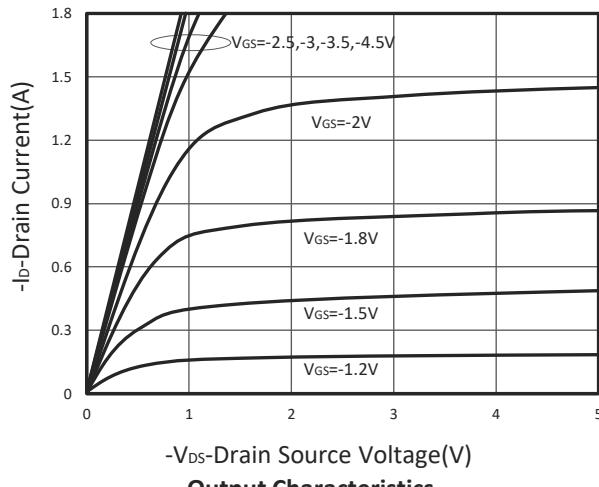
Symbol	Parameter	Condition	Min	Typ	Max	Unit	
Static Parameters							
BV_{DSS}	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=-250\mu\text{A}$	-20			V	
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=-250\mu\text{A}$	-0.5	-0.7	-1	V	
I_{GSS}	Gate Leakage Current	$\text{V}_{\text{DS}}=0\text{V}, \text{V}_{\text{GS}}=\pm 8\text{V}$			± 10	μA	
I_{DSS}	Zero Gate Voltage Drain Current	$\text{V}_{\text{DS}}=-20\text{V}, \text{V}_{\text{GS}}=0\text{V}, \text{T}_J=25^\circ\text{C}$		1		μA	
		$\text{V}_{\text{DS}}=-12\text{V}, \text{V}_{\text{GS}}=0\text{V}, \text{T}_J=85^\circ\text{C}$			-10		
$\text{R}_{\text{DS(ON)}}$	Drain-source On-Resistance ^D	$\text{V}_{\text{GS}}=-4.5\text{V}, \text{I}_D=-0.54\text{A}$		560	680	$\text{m}\Omega$	
		$\text{V}_{\text{GS}}=-2.5\text{V}, \text{I}_D=-0.3\text{A}$		740	900		
		$\text{V}_{\text{GS}}=-1.8\text{V}, \text{I}_D=-0.2\text{A}$		1000	1300		
		$\text{V}_{\text{GS}}=-1.5\text{V}, \text{I}_D=-0.1\text{A}$		1400	1800		
G_{fs}	Forward Transconductance	$\text{V}_{\text{DS}}=-5\text{V}, \text{I}_D=-0.5\text{A}$		1		S	
Diode Characteristics							
V_{SD}	Diode Forward Voltage ^D	$\text{I}_S=-0.2\text{A}, \text{V}_{\text{GS}}=0\text{V}$			-1	V	
I_S	Diode Continuous Forward Current				-0.32	A	
t_{rr}	Reverse Recovery Time	$\text{I}_S=-0.5\text{A}, \frac{d\text{I}}{dt}=100\text{A}/\mu\text{s}$		9		ns	
Q_{rr}	Reverse Recovery Charge			0.7		nC	
Dynamic and Switching Parameters ^F							
Q_g	Total Gate Charge	$\text{V}_{\text{DS}}=-10\text{V}, \text{V}_{\text{GS}}=-4.5\text{V}$ $\text{I}_D=-0.5\text{A}$		0.8		nC	
Q_{gs}	Gate-Source Charge			0.17			
Q_{gd}	Gate-Drain Charge			0.19			
C_{iss}	Input Capacitance	$\text{V}_{\text{DS}}=-10\text{V}, \text{V}_{\text{GS}}=0\text{V}, f=1\text{MHz}$		55		pF	
C_{oss}	Output Capacitance			5.6			
C_{rss}	Reverse Transfer Capacitance			4.6			
$\text{t}_{\text{d(on)}}$	Turn-On Time	$\text{V}_{\text{DD}}=-10\text{V}, \text{V}_{\text{GS}}=-4.5\text{V}$ $\text{R}_G=3\Omega, \text{I}_D=-0.5\text{A}$		4.6	9	nS	
t_r				6.2	12		
$\text{t}_{\text{d(off)}}$	Turn-Off Time			16	30		
t_f				25	48		

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

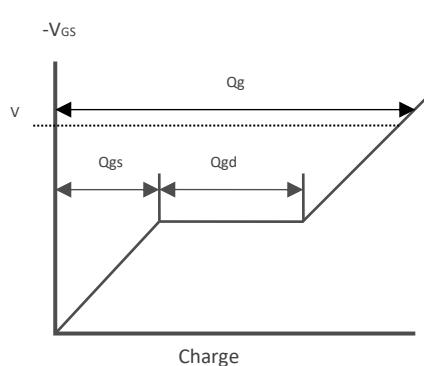
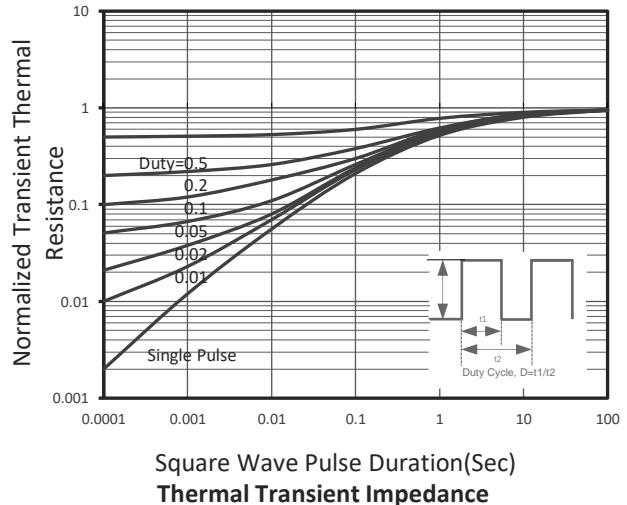
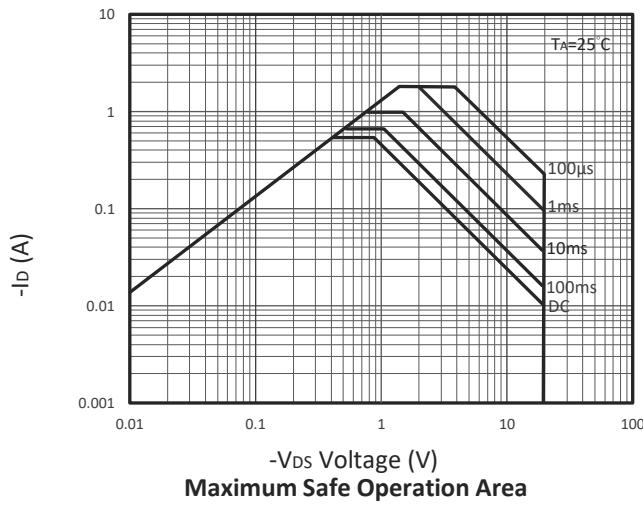
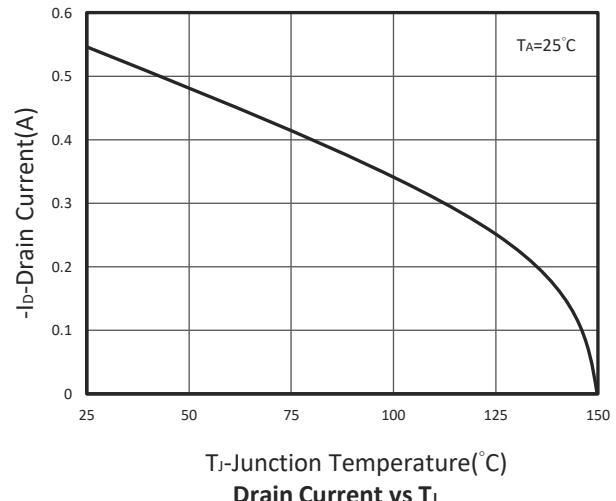
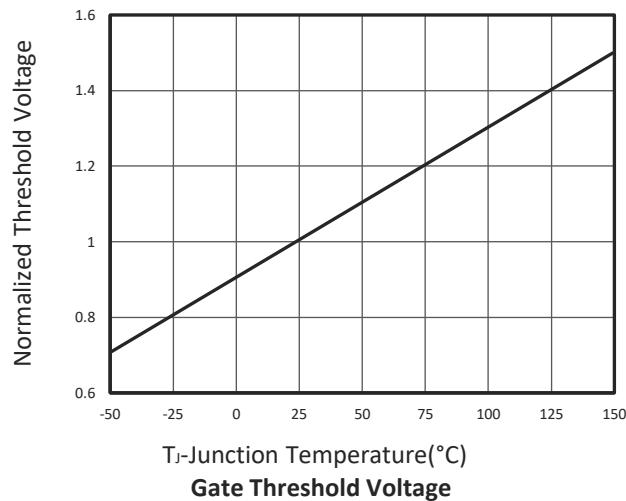
- A. Surface mounted on FR4 board using 1 in² pad size.
- B. Pulsed width limited by maximum junction temperature, $\text{T}_J(\text{MAX})=150^\circ\text{C}$ (initial temperature $\text{T}_J=25^\circ\text{C}$).
- C. Using $\leq 10\text{s}$ junction-to-ambient thermal resistance is base on $\text{T}_J(\text{MAX})=150^\circ\text{C}$.
- D. Pulse test width $\leq 300\mu\text{s}$ and duty cycle $\leq 2\%$.
- E. The EAS data shows maximum, The test condition is $\text{V}_{\text{DD}}=25\text{V}, \text{V}_{\text{GS}}=10\text{V}, \text{L}=0.1\text{mH}, \text{I}_{\text{AS}}=45\text{A}$
- F. Guaranteed by design, not subject to production testing.

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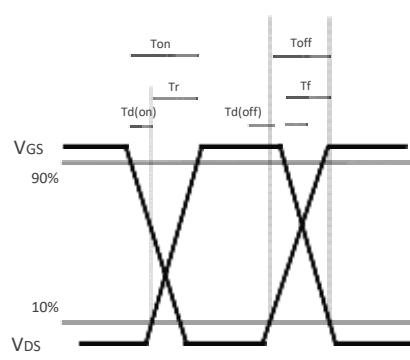
■ TYPICAL CHARACTERISTICS



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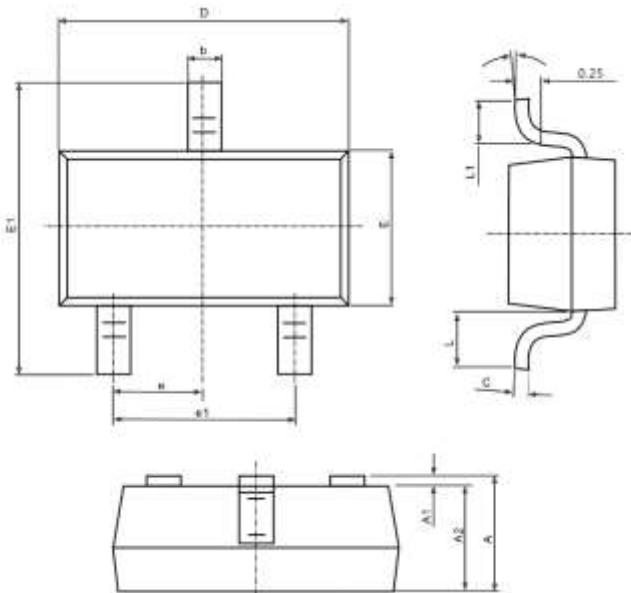


Gate Charge Waveform

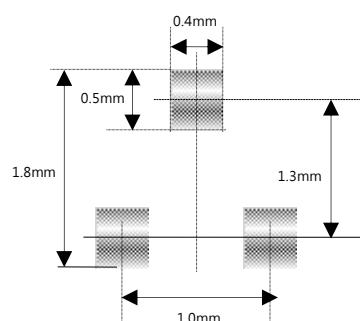


Switching Time Waveform

SOT-523 PACKAGE DIMENSIONS



Recommended Land Pattern



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.700	0.900	0.028	0.035
A1	0.000	0.100	0.000	0.004
A2	0.700	0.800	0.028	0.031
b	0.250	0.350	0.010	0.014
c	0.100	0.200	0.004	0.008
D	1.500	1.750	0.059	0.069
E	0.700	0.900	0.028	0.035
E1	1.400	1.750	0.055	0.069
e	0.500 TYP.		0.020 TYP..	
e1	0.900	1.100	0.035	0.043
L	0.300	0.460	0.012	0.018
L1	0.260	0.460	0.010	0.018
Θ	0°	8°	0°	8°